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December 2013

IRL640A

N-Channel Logic Level A-FET 200 V, 18 A, 180 m Ω

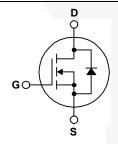
Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supplies, DC-AC converters for uninterrupted power supply and motor control.

Features

- 18 A, 200 V, $R_{DS(on)}$ = 180 m Ω @ V_{GS} = 5 V
- Low Gate Charge (Typ. 40 nC)
- Low Crss (Typ. 95 pF)
- · Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- · Logic-Level Gate Drive





Absolute Maximum Ratings

| Symbol | Characteristic | Value | Units |
|------------------|--|--------------|-------|
| V _{DSS} | Drain-to-Source Voltage | 200 | V |
| ı | Continuous Drain Current (T _C =25°C) | 18 | |
| I _D | Continuous Drain Current (T _C =100°C) | 11.4 | A |
| I _{DM} | Drain Current-Pulsed (1) | 63 | Α |
| V_{GS} | Gate-to-Source Voltage | ±20 | V |
| E _{AS} | Single Pulsed Avalanche Energy (2) | 64 | mJ |
| I _{AR} | Avalanche Current (1) | 18 | Α |
| E _{AR} | Repetitive Avalanche Energy (1) | 11 | mJ |
| dv/dt | Peak Diode Recovery dv/dt (3) | 5 | V/ns |
| | Total Power Dissipation (T _C =25°C) | 110 | W |
| P_{D} | Linear Derating Factor | 0.88 | W/°C |
| | Operating Junction and | 55 (450 | |
| T_J , T_STG | Storage Temperature Range | - 55 to +150 | |
| _ | Maximum Lead Temp. for Soldering | 000 | °C |
| T_L | Purposes, 1/8. from case for 5-seconds | 300 | |

Thermal Resistance

| Symbol | Characteristic | Тур. | Max. | Units |
|-----------------|---------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case | | 1.14 | |
| $R_{\theta CS}$ | Case-to-Sink | 0.5 | | °C/W |
| $R_{\theta JA}$ | Junction-to-Ambient | | 62.5 | |

Package Marking and Ordering Information

| Part Number | Top Mark | Package | Packing Method | Reel Size | Tape Width | Quantity |
|-------------|----------|---------|----------------|-----------|------------|----------|
| IRL640A | IRL640A | TO-220 | Tube | N/A | N/A | 50 units |

Electrical Characteristics ($T_{\rm C}$ =25 $^{\circ}{\rm C}$ unless otherwise specified)

| Symbol | Characteristic | Min. | Тур. | Max. | Units | Test Condition | |
|------------------------|---------------------------------|------|------|------|-------|---|--|
| BV _{DSS} | Drain-Source Breakdown Voltage | 200 | | | V | $V_{GS} = 0V, I_{D} = 250 \mu A$ | |
| $\Delta BV/\Delta T_J$ | Breakdown Voltage Temp. Coeff. | | 0.17 | | V/°C | I _D =250μA See Fig 7 | |
| $V_{GS(th)}$ | Gate Threshold Voltage | 1.0 | | 2.0 | V | $V_{DS} = 5V, I_{D} = 250 \mu A$ | |
| ı | Gate-Source Leakage, Forward | | | 100 | nA | V _{GS} =20V | |
| I _{GSS} | Gate-Source Leakage, Reverse | | | -100 | ПА | V _{GS} =-20V | |
| | Dunin to Course I column Cumant | | | 10 | | V _{DS} =200V | |
| I _{DSS} | Drain-to-Source Leakage Current | | - | 100 | μΑ | V _{DS} =160V,T _C =125°C | |
| B | Static Drain-Source | | | | | V 5VI 0A (4) | |
| R _{DS(on)} | On-State Resistance | | | 0.18 | Ω | $V_{GS}=5V,I_{D}=9A \qquad (4)$ | |
| g _{fs} | Forward Transconductance | | 13.3 | | Ω | $V_{DS} = 40V, I_{D} = 9A$ (4) | |
| C _{iss} | Input Capacitance | | 1310 | 1705 | | \\ 0\\\\ 25\\\$ 4MH= | |
| C _{oss} | Output Capacitance | | 200 | 250 | рF | $V_{GS}=0V, V_{DS}=25V, f=1MHz$ | |
| C _{rss} | Reverse Transfer Capacitance | | 95 | 120 | | See Fig 5 | |
| t _{d(on)} | Turn-On Delay Time | | 11 | 30 | | V 400VI 40A | |
| t _r | Rise Time | | 8 | 25 | | $V_{DD} = 100 V, I_{D} = 18 A,$ | |
| t _{d(off)} | Turn-Off Delay Time | | 46 | 100 | ns | $R_G=4.6\Omega$ | |
| t _f | Fall Time | | 15 | 40 | | See Fig 13 (4) (5) | |
| Q_g | Total Gate Charge | | 40 | 56 | | $V_{DS} = 160 V, V_{GS} = 5 V,$ | |
| Q_gs | Gate-Source Charge | | 6.8 | | nC | I _D =18A | |
| Q_{gd} | Gate-Drain (. Miller.) Charge | | 18.6 | | | See Fig 6 & Fig 12 (4) (5) | |

Source-Drain Diode Ratings and Characteristics

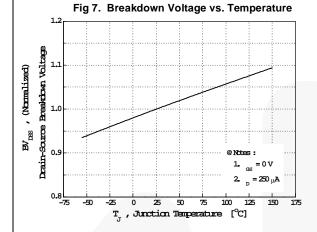
| Symbol | Characteristic | Min. | Тур. | Max. | Units | Test Condition |
|-----------------|---------------------------|------|------|------|-------|--|
| I _S | Continuous Source Current | | 1 | 18 | ^ | Integral reverse pn-diode |
| I _{SM} | Pulsed-Source Current (1) | | 1 | 63 | Α | in the MOSFET |
| V_{SD} | Diode Forward Voltage (4) | | I | 1.5 | V | T _J =25°C,I _S =18A,V _{GS} =0V |
| t _{rr} | Reverse Recovery Time | | 224 | | ns | T _J =25°C,I _F =18A |
| Q _{rr} | Reverse Recovery Charge | | 1.55 | | μС | $di_F/dt=100A/\mu s$ (4) |

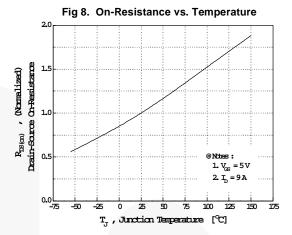
Notes:

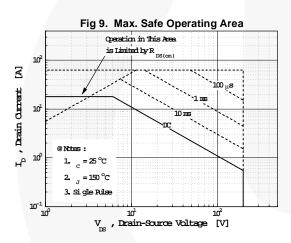
- (1) Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- (2) L=0.3mH, I_{AS}=18A, V_{DD}=50V, R_G=27 Ω , Starting T_J=25°C
- (3) $I_{SD} \le 18A$, $di/dt \le 260A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$ (4) Pulse Test: Pulse Width = 250 μs , Duty Cycle $\le 2\%$
- (5) Essentially Independent of Operating Temperature

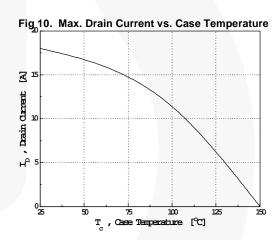
Typical Characteristics Fig 1. Output Characteristics Fig 2. Transfer Characteristics V_{GS} Top: 60 V 55 V ₹ Ξ 10¹ 45V 40V Ip , Drain Current 10¹ Drain Current 35 V Bottom: 3.0 V 100 1. $_{\rm GS}$ = 0 V _{DS} = 40 V 2. 1. 25 μs Pulse c = 25 °C 10⁻¹ 10⁻¹ 10° 10¹ V Drain-Source Voltage [V] V_{GS} , Gatte-Source Voltage [V] Fig 3. On-Resistance vs. Drain Current Fig 4. Source-Drain Diode Forward Voltage ₹ In , Reverse Drain Current Drain-Source On-Resistance 10¹ $R_{be(cm)}$, [Ω] 0.1 1. _{GS} = 0 V @Note: $T_{_{\!\mathcal{I}}} = 25\,^{\circ}\mathrm{C}$ 2. 25 μ s Rulse Test 0.0 10 I , Drain Current [A] 0.4 1.0 1.2 1.4 1.6 V_{SD} , Source-Drain Voltage [V] Fig 5. Capacitance vs. Drain-Source Voltage Fig 6. Gate Charge vs. Gate-Source Voltage C_{iss}=C_{gs}+C_{gd} (C_{ds}=shorted) $C_{oss} = C_{ds} + C_{gd}$ Crss=Cgd $V_{DS} = 40 \text{ V}$ Σ $V_{DS} = 100 \text{ V}$ ď $V_{\rm GB}$, Gatte-Source Voltage V_{DS} = 160 V Capacitance @ Notes: 1. $V_{GS} = 0 \text{ V}$ 2. f = 1 MHz 0L 20 30 40 Q, , Total Gate Charge [nC] V_{DS} , Drain-Source Voltage [V]

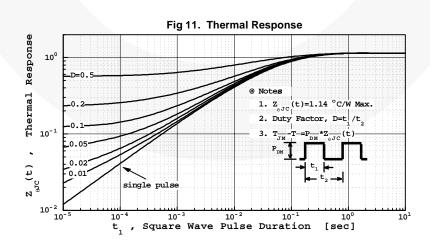
Typical Characteristics (continued)











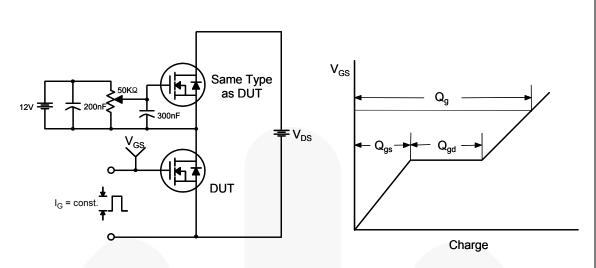


Figure 12. Gate Charge Test Circuit & Waveform

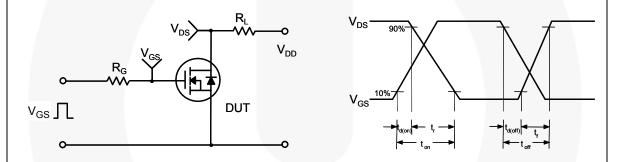


Figure 13. Resistive Switching Test Circuit & Waveforms

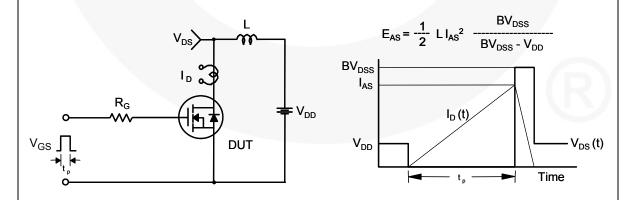
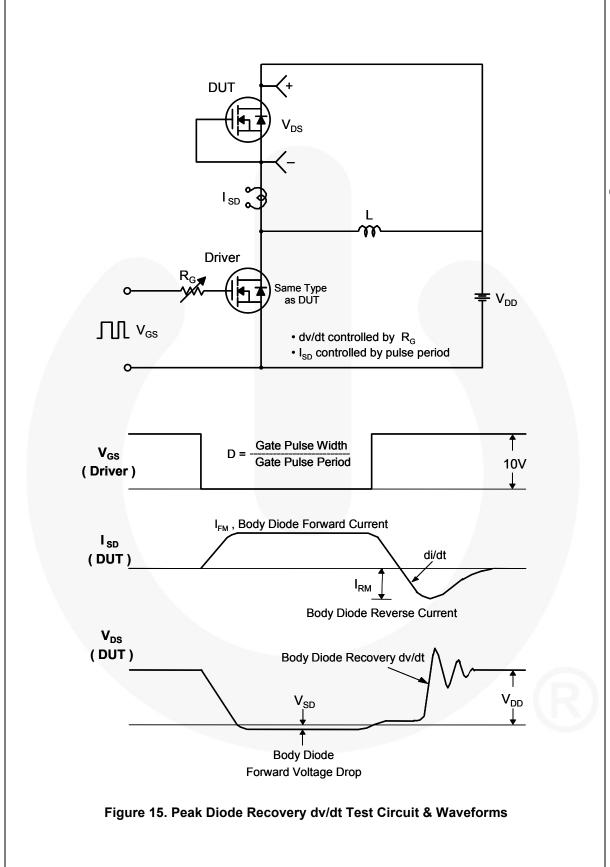


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



Mechanical Dimensions

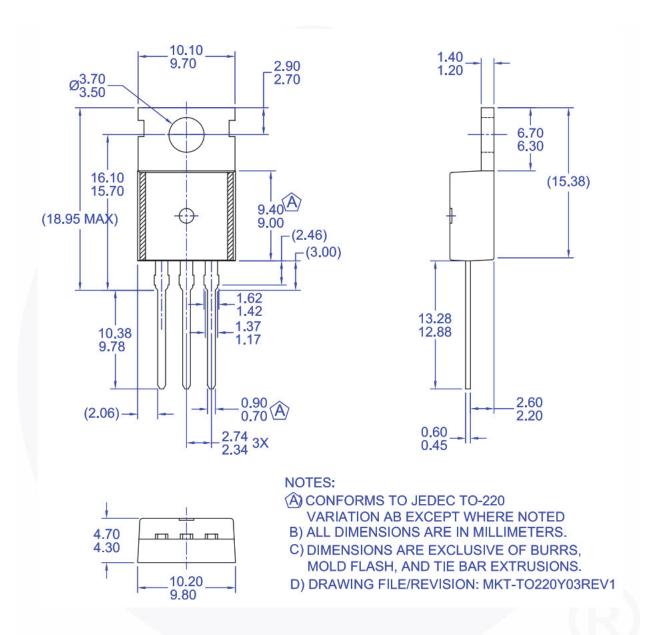


Figure 16. TO220, Molded, 3-Lead, Jedec Variation AB

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